Fermilab U.S. DEPARTMENT OF ENERGY Office of Science

Analysis of Low RRR SRF Cavities

Katrina Howard, Daniel Bafia, Young-Kee Kim, Anna Grassellino

IPAC'22

14 June 2022

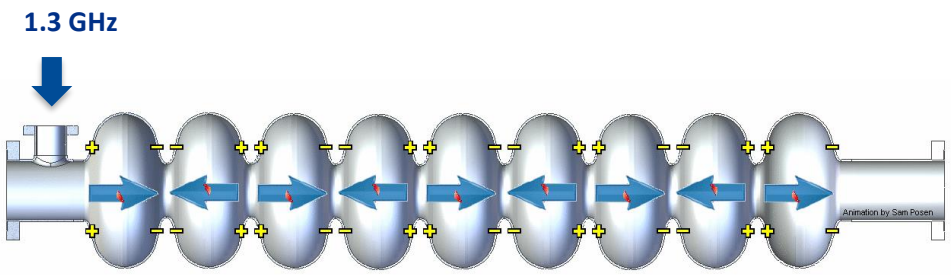
In partnership with:

THE UNIVERSITY OF CHICAGO

Introduction to Superconducting Radio Frequency (SRF) Cavities

- SRF cavities are resonant structures made from high purity niobium that generate the accelerating electric field along the beamline inside particle accelerators
- Purity measured by residual resistance ratio (RRR)
- Cavity performance determined by first ~100 nm of material
- Goals of SRF studies is to design surface profile to increase:
  - quality factor (efficiency)
  - accelerating gradient

$$Q_0 = \frac{G}{R_s} \sim$$ **Number of oscillations to dissipate stored energy**



Motivation for Low RRR Investigation

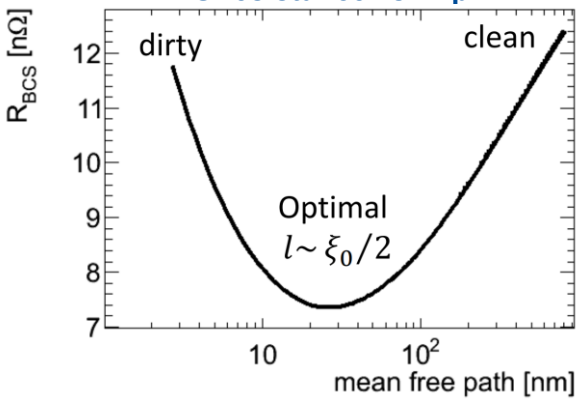
$$R_s(T) = R_{res}(< 1.5\ K) + R_{BCS}(T)$$

Temperature Independent

Temperature Dependent

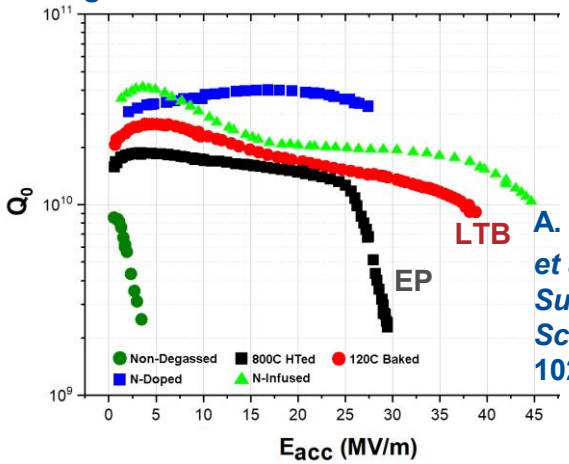
- Many SRF studies follow a “clean bulk dirty surface” technique to optimize the BCS resistance by adding extrinsic impurities
  - Low temperature bake diffuses oxygen into surface
- What role do intrinsic impurities serve?
  - Lower the mfp so may experience low BCS resistance behavior
  - Might perform similar functions as extrinsic impurities which have been shown to improve performance

BCS resistance vs mfp



A. Miyazaki SRF2021 Tutorial

Q vs gradient for different surface treatments



A. Grassellino *et al* 2013 *Supercond. Sci. Technol.* 26 102001

Fermilab

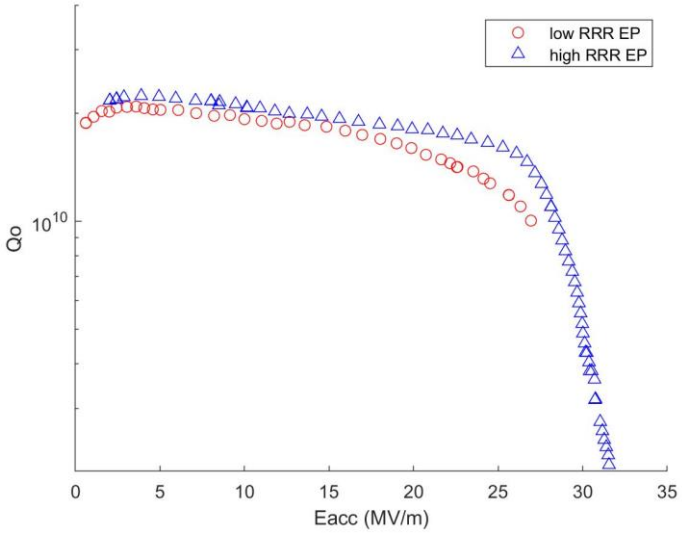
THE UNIVERSITY OF CHICAGO

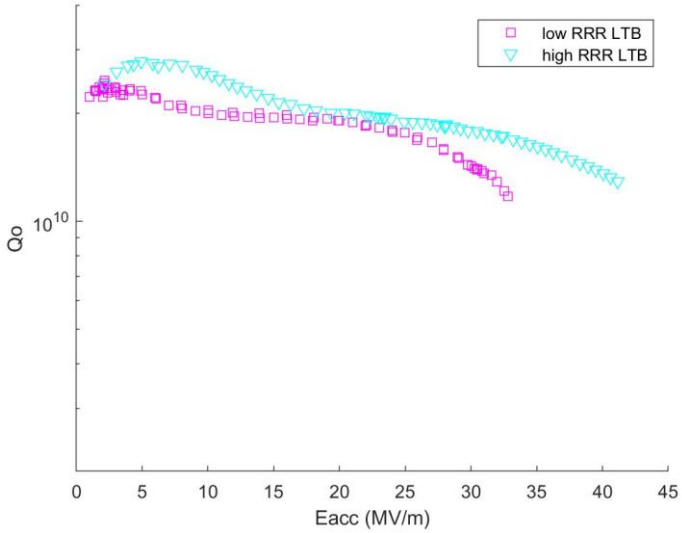
Low RRR Analysis Components

- Baseline testing on 1.3 GHz TESLA-shaped single-cell low RRR (= 61) cavity in electropolished (EP) condition
  - Quality factor vs accelerating gradient at 2 K and low T (< 1.5 K)
  - Residual resistance vs gradient
  - BCS resistance vs gradient
  - Frequency vs temperature
- Repeat testing after surface treatment
  - Low temperature bake (120 ℃ x 48 hours)

Cavity testing facility at Fermilab

Quality Factor vs Accelerating Gradient at 2 K





Electropolished

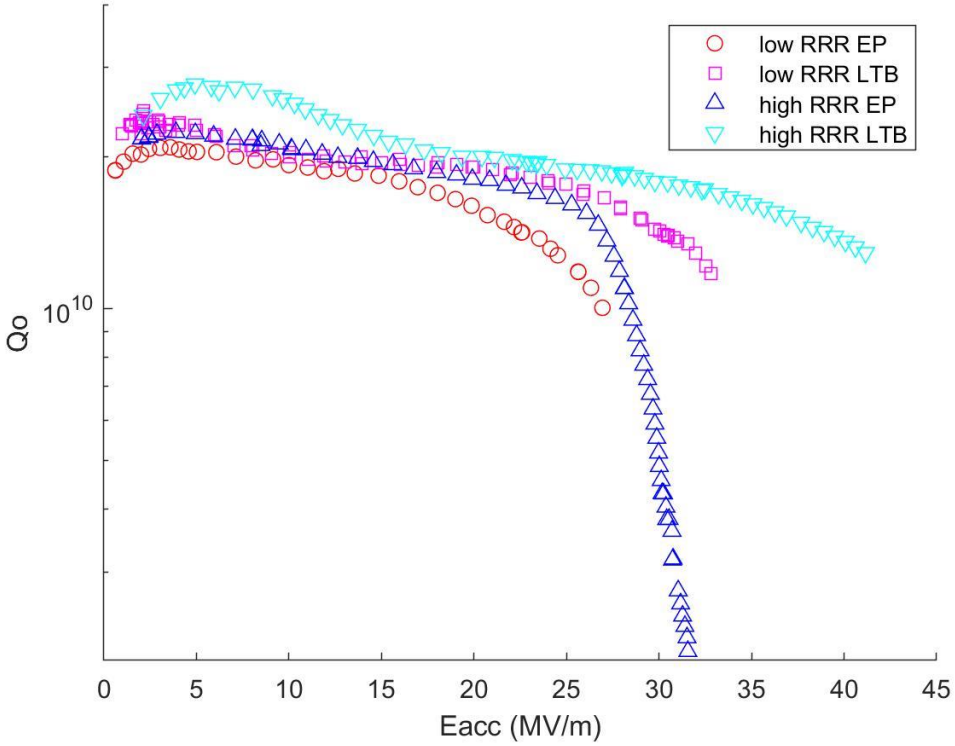
- **Low RRR has slightly lower Q_0 at all gradients and does not reach as high gradient**
- **Q_0 slope begins sooner but less sharp**

Low Temperature Bake

- **Low RRR does not experience "bump" of anti Q_0 slope at low gradient**
- **Performance is extended from EP but not as far as high RRR**

Fermilab

Quality Factor vs Accelerating Gradient at 2 K

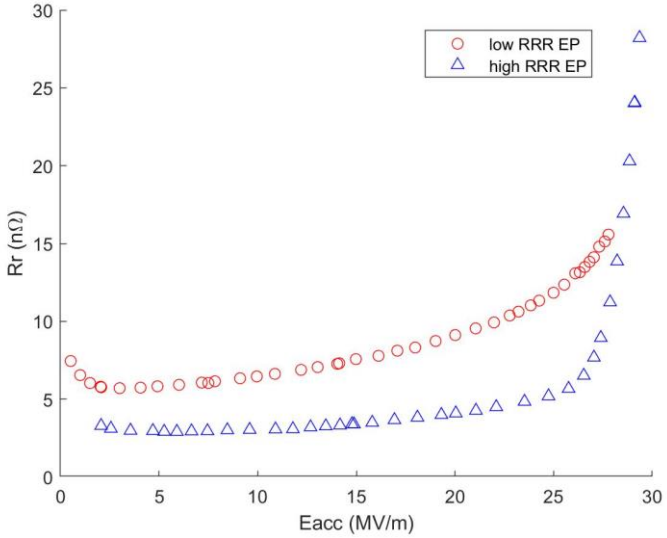


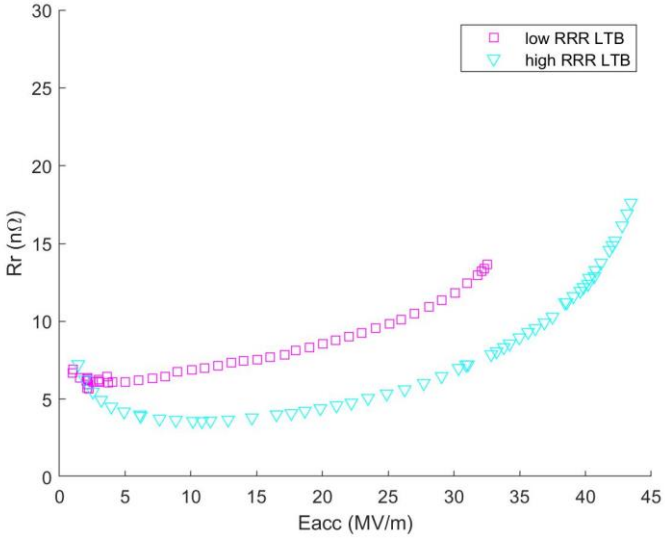
LTB improves performance of low RRR cavity but in a different way than we see in high RRR cavities

- Performance of all cavities is similar at medium gradients
- LTB delays Q_0 slope in low RRR but less extreme difference than high RRR
- Low RRR does not experience anti Q_0 slope after LTB

Residual Resistance vs Accelerating Gradient

$$R_{res} = \frac{G=270\ \Omega}{Q_0(low\ T)}$$





Electropolished

- **Low RRR almost always a few nΩ higher than high RRR**

Low Temperature Bake

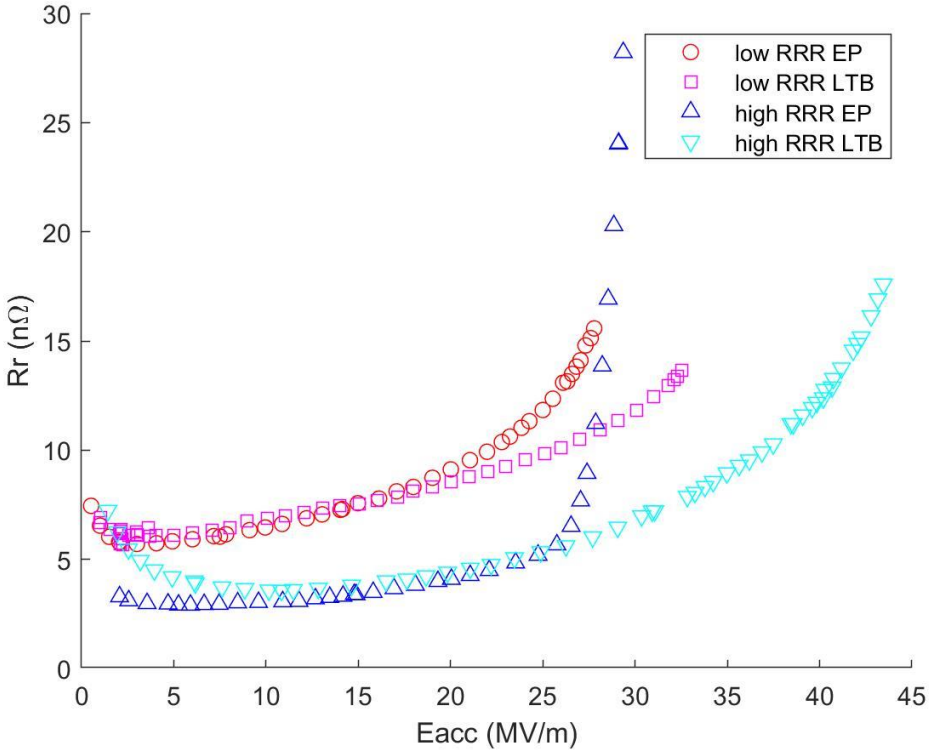
- **Similar at low field but then low RRR steadily increases**
- **Parallel at high field**

Fermilab

THE UNIVERSITY OF CHICAGO

Residual Resistance vs Accelerating Gradient

$$R_{res} = \frac{G=270\ \Omega}{Q_0(low\ T)}$$



Low RRR and high RRR have similar residual resistance response to LTB

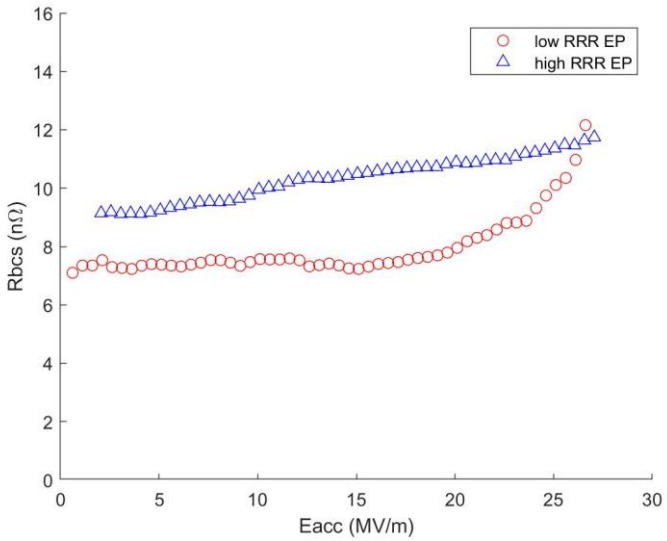
- Low RRR EP and LTB nearly equal until ~20 MV/m
- High RRR EP and LTB same at medium field
- Low RRR almost always larger residual resistance than high RRR

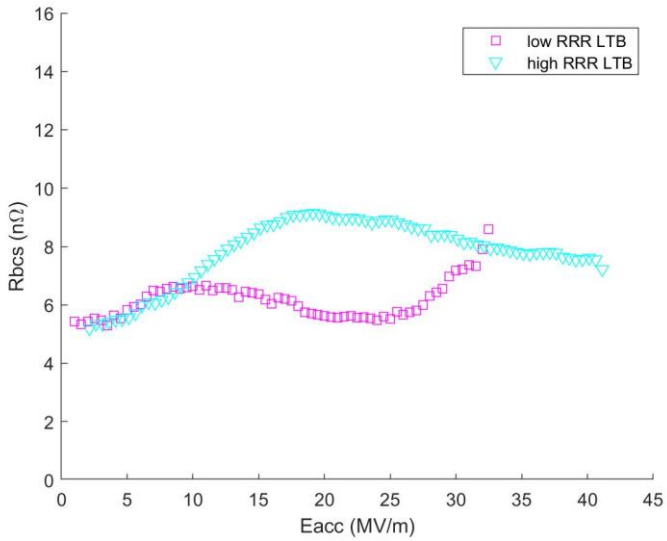
Fermilab

THE UNIVERSITY OF CHICAGO

BCS Resistance vs Accelerating Gradient

$$R_{BCS}(2\,K) = R_s(2\,K) - R_{res}$$





Electropolished

- **Low RRR is significantly lower except at high field**

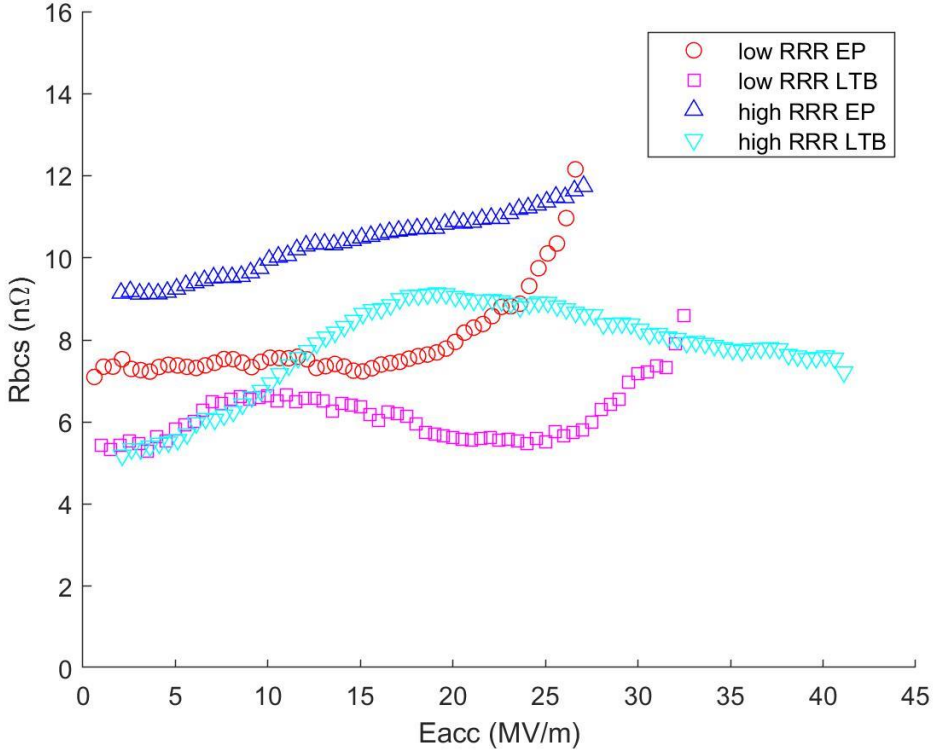
Low Temperature Bake

- **High and low RRR equal until ~10 MV/m**
- **Low RRR has lower BCS resistance at mid field**

Fermilab

BCS Resistance vs Accelerating Gradient

$$R_{BCS}(2\,K) = R_s(2\,K) - R_{res}$$



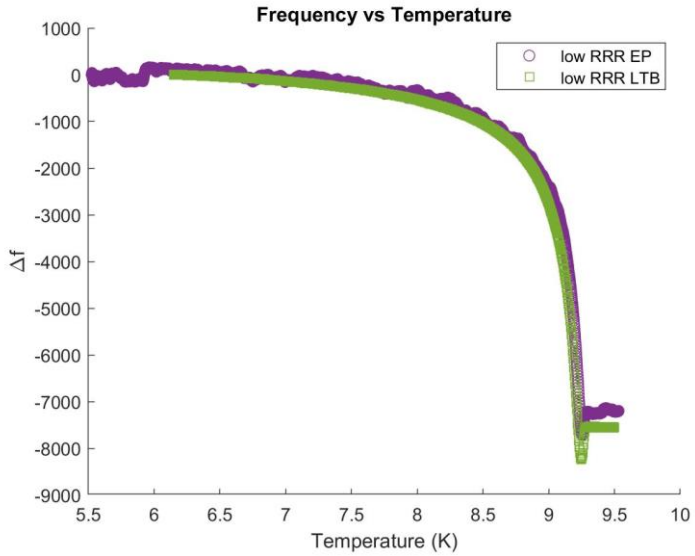
Low RRR exhibits low BCS behavior

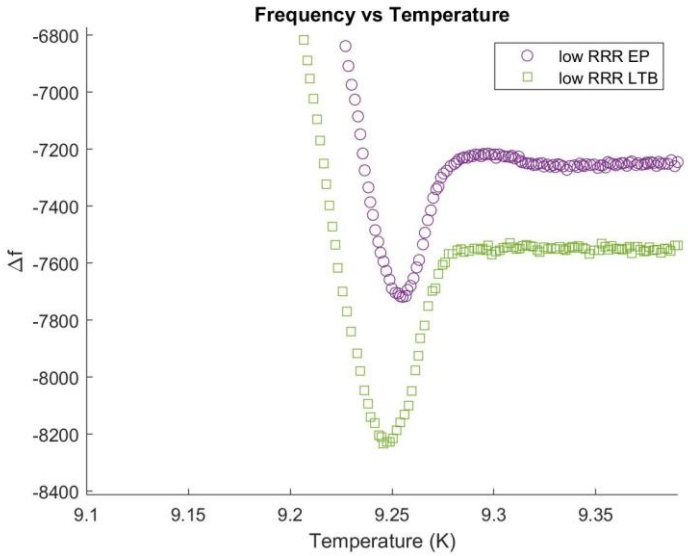
- EP → LTB causes downright shift in BCS resistance
- Low RRR BCS is lowest at mid field
- Any benefit of dirty surface is lost at high field

Fermilab

THE UNIVERSITY OF CHICAGO

Frequency vs Temperature

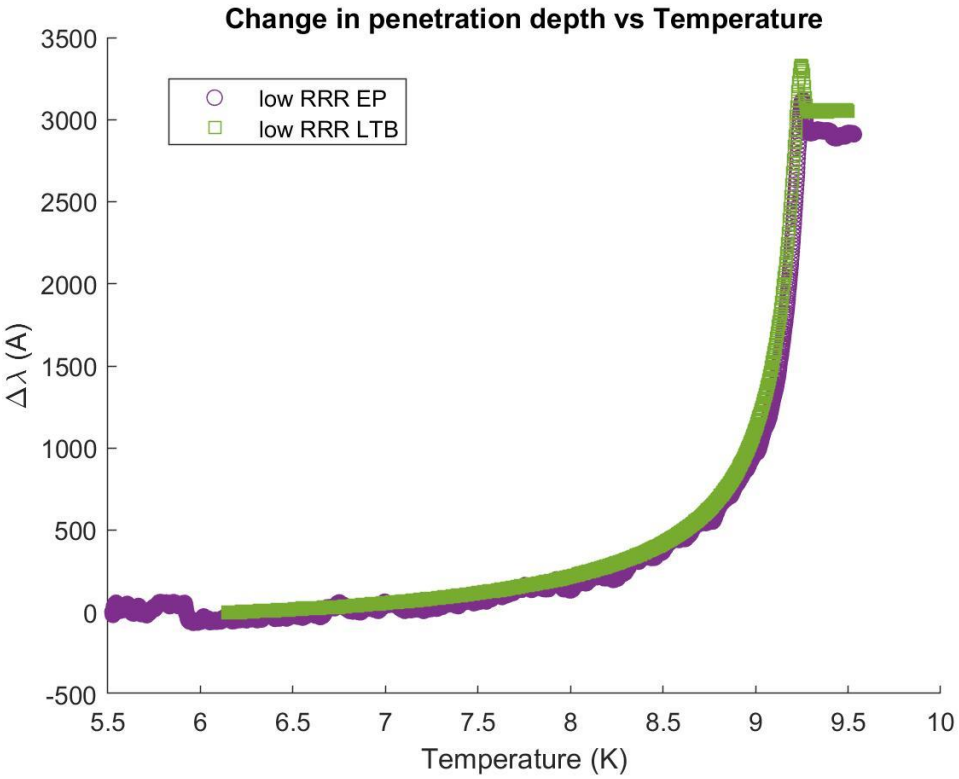




- **EP and LTB experience ~7.5 kHz change in resonant frequency through T_c**

- **Dip in EP and LTB → doped behavior**
- **Experimental T_c for both ~9.28 K**

Change in Penetration Depth vs Temperature

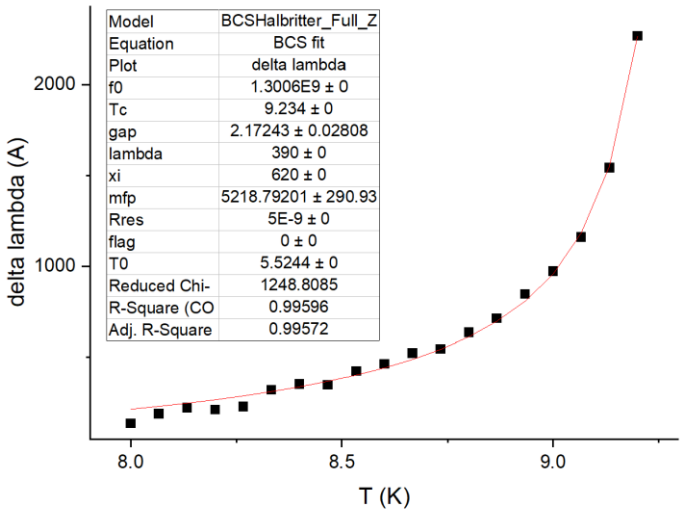


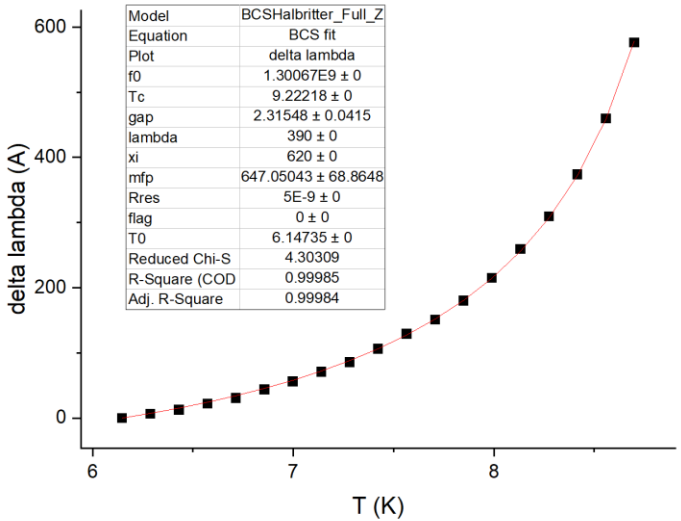
$$\Delta\lambda(T) = -\frac{G\Delta f(T)}{\mu_0 f^2(T_0)}$$

Need to convert to penetration depth to use fitting program to find mfp and gap

- G = 270 Ω (geometry factor)
- $\Delta f(T)$ = change in frequency vs temperature
- μ_0 = magnetic permeability
- $f(T_0)$ = constant resonant frequency at low temperature

Nonlinear Fitting using SRIMP Program





Electropolished

- **mfp = 522 ± 29 nm**
- **gap = 2.17 ± .03**

Low Temperature Bake

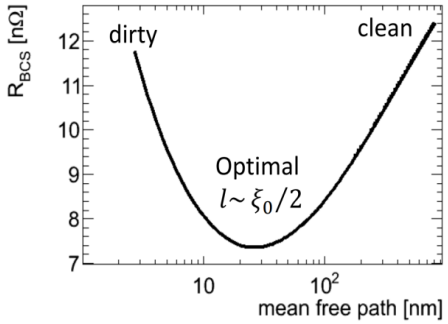
- **mfp = 64.7 ± 6.9 nm → decrease suggests decreased BCS resistance**
- **gap = 2.32 ± .04 → increase suggests doped behavior**

Fermilab

Summary

- Low RRR cavity in EP condition behaves differently than high RRR EP
  - Intrinsic impurities do have significant impact on RF behavior
- Low RRR cavity in LTB condition behaves similarly to high RRR LTB with some offset
  - Addition of oxygen into RF layer allows for higher quality factor and accelerating gradients without increasing the residual resistance from EP
  - How does oxygen behave differently in a Nb lattice with more impurities?
- Low RRR shows:
  - consistently high residual resistance
  - low BCS resistance, especially at mid gradient
  - dip on frequency versus temperature near Tc
  - decrease in mfp and increase in gap from EP → LTB

Recall:



Next Steps

- Processing additional data from LTB testing
  - Temperature-mapping to observe local heating and quench
- N-doping cavity
- Sample study on low RRR material
  - Process coupons to establish EP, LTB, and N-doped conditions
  - Secondary-ion mass spectrometry to observe impurity profile
  - Microscopy to characterize surface

Questions?

This manuscript has been authored by Fermi Research Alliance, LLC under Contract No. DE-AC02-07CH11359 with the U.S. Department of Energy, Office of Science, Office of High Energy Physics. This work was supported by the University of Chicago.